Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,376	TOYAMA ET AL	
Examiner	Art Unit	
Wilson Tsui	2178	

	SFAR	CHED	
	- OLAN		1
Class	Subclass	Date	Examiner
715	512	1/9/2007	WT
715	513	1/9/2007	wr
715	731	1/9/2007	WT
709	223	1/9/2007	WT

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING SEAR	NOTES CH STRATEGY	<b>'</b> )
	DATE	EXMR
East Search USPAT, USPGPUB See Notes	1/9/2007	WT
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